



TEST REPORT

Test report no.: 1-6080/13-01-08-A



Testing laboratory

CETECOM ICT Services GmbH

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Accredited Testing Laboratory:

The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2005) by the Deutsche Akkreditierungsstelle GmbH (DAkkS)

The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate with

the registration number: D-PL-12076-01-01
Area of Testing: Radio/Satellite Communications

Applicant

FLIR Systems AB

Antennvägen 6
18715 Täby / SWEDEN
Contact: Göran Skedung
e-mail: goran.skedung@flir.se
Phone: +46 87 53 27 59

Manufacturer

FLIR Systems AB

Antennvägen 6 18715 Täby / SWEDEN

Test standard/s

47 CFR Part 15 Title 47 of the Code of Federal Regulations; Chapter I

Part 15 - Radio frequency devices

RSS - 210 Issue 8 Spectrum Management and Telecommunications - Radio Standards Specification

Low-power Licence-exempt Radiocommunication Devices (All Frequency Bands):

Category I Equipment

For further applied test standards please refer to section 3 of this test report.

Test Item

Kind of test item: Infrared Camera

Model name: FLIR-E64501 (Exx)

FCC ID: ZLV-FLIRE49001

IC: 5306A-FLIRE49001

ISM band 2.4 GHz

Frequency: lowest channel 00 – 2402 MHz; highest channel 78 – 2480 MHz

Technology tested: Bluetooth®, +EDR
Antenna: Integrated antenna

Power Supply: 3.7V DC by Li-lon battery pack

Temperature Range: -/-°C to -/-°C



This test report is electronically signed and valid without handwriting signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

Test report authorised:	Test performed:		
Staten Päe	Androne Luckenhill		
Stefan Bös Senior Testing Manager	Andreas Luckenbill Expert		

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2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CETECOM ICT Services GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.

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2.2 Application details

Date of receipt of order: 2013-05-30
Date of receipt of test item: 2013-06-11
Start of test: 2013-06-11
End of test: 2013-06-14

Person(s) present during the test: -/-

3 Test standard/s

Test standard	Date	Test standard description
47 CFR Part 15	01.10.2012	Title 47 of the Code of Federal Regulations; Chapter I Part 15 - Radio frequency devices
RSS - 210 Issue 8	01.12.2010	Spectrum Management and Telecommunications - Radio Standards Specification Low-power Licence-exempt Radiocommunication Devices (All Frequency Bands): Category I Equipment

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4 Test environment

T_{nom} +22 °C during room temperature tests

Temperature: T_{max} -/- °C during high temperature tests

T_{min} -/- °C during low temperature tests

Relative humidity content: 55 %

Barometric pressure: not relevant for this kind of testing

V_{nom} 3.7 V DC by Li-Ion battery pack

Power supply: V_{max} -/- V

V_{min} -/- V

5 Test item

Kind of test item	:	Infrared Camera
Type identification	:	FLIR-E64501 (Exx)
S/N serial number	:	Rad. 49038203, 49038150
HW hardware status	:	ERCO board -01
SW software status	:	rev. 0.31G.2T
Frequency band [MHz]	:	ISM band 2.4 GHz lowest channel 00 – 2402 MHz; highest channel 78 – 2480 MHz
Type of radio transmission Use of frequency spectrum		FHSS
Type of modulation	:	GFSK, Pi/4 DQPSK, 8DPSK
Number of channels	:	79
Antenna	:	Integrated antenna
Power supply	:	3.7 V DC by Li-lon battery pack
Temperature range	:	-/-°C to -/-°C

5.1 Additional information

Test setup- and EUT-photos are included in test reports:

External photos of the EUT: 1-6080/13-01-01_AnnexA Internal photos of the EUT: 1-6080/13-01-01_AnnexB Testsetup photos: 1-6080/13-01-01_AnnexD

6 Test laboratories sub-contracted

None

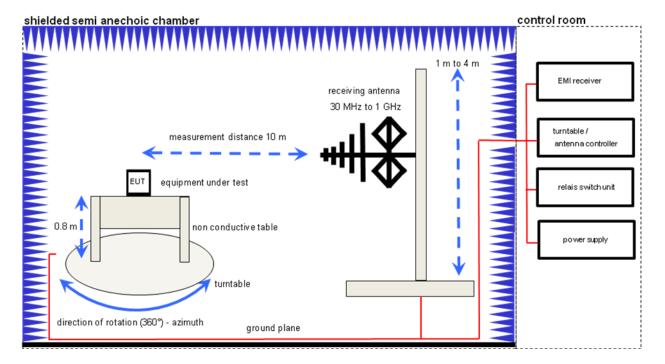
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7 Description of the test setup

7.1 Radiated measurements chamber F

The radiated measurements are performed in vertical and horizontal plane in the frequency range from 9 kHz to 1 GHz in semi-anechoic chambers. The EUT is positioned on a non-conductive support with a height of 0.80 m above a conductive ground plane that covers the whole chamber. The receiving antennas are confirmed with specifications ANSI C63. These antennas can be moved over the height range between 1.0 m and 4.0 m in order to search for maximum field strength emitted from EUT. The measurement distances between EUT and receiving antennas are indicated in the test setups for the various frequency ranges. For each measurement, the EUT is rotated in all three axes until the maximum field strength is received. The wanted and unwanted emissions are received by spectrum analysers where the detector modes and resolution bandwidths over various frequency ranges are set according to requirement ANSI C63.



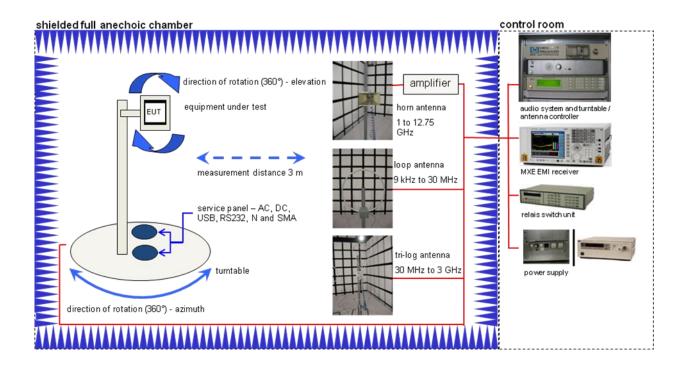
Equipment table:

Equipment	Туре	Manufacturer	Serial No.	INV. No Cetecom
Switch-Unit	3488A	HP Meßtechnik	2719A14505	300000368
DC power supply, 60Vdc, 50A, 1200 W	6032A	HP Meßtechnik	2920A04466	300000580
EMI Test Receiver	ESCI 3	R&S	100083	300003312
Amplifier	JS42-00502650-28-5A	MITEQ	1084532	300003379
Antenna Tower	Model 2175	ETS-LINDGREN	64762	300003745
Positioning Controller	Model 2090	ETS-LINDGREN	64672	300003746
Turntable Interface- Box	Model 105637	ETS-LINDGREN	44583	300003747
TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	295	300003787

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7.2 Radiated measurements chamber C



Equipment table:

Equipment	Туре	Manufacturer	Serial No.	INV. No Cetecom	
MXE EMI Receiver 20 Hz bis 26,5 GHz	N9038A	Agilent Technologies	MY51210197	300004405	
TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	371	300003854	
Band Reject filter	WRCG2400/2483- 2375/2505-50/10SS	Wainwright	11	300003351	
Highpass Filter	WHKX7.0/18G-8SS	Wainwright	18	300003789	
Double-Ridged Waveguide Horn Antenna 1-18.0GHz	3115	EMCO	8812-3088	300001032	
Active Loop Antenna	6502	EMCO	8905-2342	300000256	
Anechoic chamber	choic chamber FAC 3/5m		87400/02	300000996	
Switch / Control Unit	3488A	HP Meßtechnik	*	300000199	
Switch / Control Unit	3488A	HP Meßtechnik	2719A15013	300001156	
Isolating Transformer	MPL IEC625 Bus Regeltrenntravo	Erfi	91350	300001155	
Three-Way Power Splitter, 50 Ohm	11850C	HP Meßtechnik		300000997	
Amplifier	js42-00502650-28-5a	Parzich GMBH 928979		300003143	

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7.3 Radiated measurements 12.75 GHz to 25 GHz



Equipment table:

Equipment	Туре	Manufacturer	Serial No.	INV. No Cetecom
Std. Gain Horn Antenna 12.4 to 18.0 GHz	639	Narda		300000786
Std. Gain Horn Antenna 18.0 to 26.5 GHz	638	Narda		300000486
Microwave System Amplifier, 0.5-26.5 GHz	83017A	HP Meßtechnik	00419	300002268
Spectrum Analyzer 20 Hz - 50 GHz	FSU50	R&S	200012	300003443
Signal Analyzer 40 GHz	FSV40	R&S	101042	300004517

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8 Summary of measurement result	S
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No deviations from the technical specifications were ascertained
There were deviations from the technical specifications ascertained

TC Identifier	Description	Verdict	Date	Remark
RF-Testing	CFR Part 15 RSS 210, Issue 8, Annex 8	Passed	2013-08-29	Reduced testplan! For full tests see 1-3325/11-02-03-A

Test specification clause	Test case	Temperature conditions	Power source voltages	Mode	Pass	Fail	NA	NP	Remark
§15.247(b)(4) RSS 210 / A8.4(2)	Antenna gain	Nominal	Nominal	GFSK				\boxtimes	reduced testplan
§15.247(e) RSS 210 / A8.2(b)	Power spectral density	Nominal	Nominal	GFSK Pi/4 DQPSK 8 DPSK					Not applicable for FHSS!
§15.247(a)(1) RSS 210 / A8.1(b)	Carrier frequency separation	Nominal	Nominal	GFSK					reduced testplan
§15.247(a)(1) RSS 210 / A8.1(d)	Number of hopping channels	Nominal	Nominal	GFSK					reduced testplan
§15.247(a)(1) (iii) RSS 210 / A8.3(1)	Time of occupancy (dwell time)	Nominal	Nominal	GFSK Pi/4 DQPSK 8 DPSK					reduced testplan
§15.247(a)(1) RSS 210 / A8.2(a)	Spectrum bandwidth of a FHSS system 20dB bandwidth	Nominal	Nominal	GFSK Pi/4 DQPSK 8 DPSK					reduced testplan
§15.247(b)(1) RSS-210 / A8.4(2)	Maximum output power	Nominal	Nominal	GFSK Pi/4 DQPSK 8 DPSK	$\boxtimes\boxtimes\boxtimes$				complies
§15.247(d) RSS-210 / A8.5	Band edge compliance conducted	Nominal	Nominal	GFSK Pi/4 DQPSK 8 DPSK					reduced testplan
§15.205 RSS-210 / A8.5	Band edge compliance radiated	Nominal	Nominal	GFSK Pi/4 DQPSK 8 DPSK	$\boxtimes \boxtimes \boxtimes$				complies
§15.247(d) RSS-210 / A8.5	TX spurious emissions conducted	Nominal	Nominal	GFSK Pi/4 DQPSK 8 DPSK					reduced testplan
§15.247(d) RSS-210 / A8.5	TX spurious emissions radiated	Nominal	Nominal	GFSK					complies
§15.109 RSS-Gen	RX spurious emissions radiated	Nominal	Nominal	-/-					complies
§15.209(a) RSS-Gen	TX spurious emissions radiated < 30 MHz	Nominal	Nominal	GFSK	\boxtimes				complies
§15.107(a)	Conducted emissions < 30 MHz	Nominal	Nominal	GFSK					reduced testplan

Note: NA = Not Applicable; NP = Not Performed

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9 Additional comments

The Bluetooth $^{\$}$ word mark and logos are owned by the Bluetooth SIG Inc. and any use of such marks by Cetecom ICT Services GmbH is under license.

Reference documents:	1-3325/11-02-03-A					
Special test descriptions:	Reduced Testplan; only radiated measurements. Hardware change on PC board, but same RF-part and antenna as in r testreport.					
Configuration descriptions:	TX tests: were performed with x-DH5 packets and static PRBS patt payload. RX/Standby tests: BT test mode enabled, scan enabled, TX Idle					
Test mode:		Bluetooth Test mode loop back enabled (EUT is controlled over CBT)				
		Special software is used. EUT is transmitting pseudo random data by itself				

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10 RSP100 test report cover sheet / performance test data

Test report number	:	1-6080/13-01-08-A				
Equipment model number	:	FLIR-E64501 (Exx)				
Certification number	:	5306A-FLIRE49001				
Manufacturer (complete address)	:	FLIR Systems AB Antennvägen 6 18715 Täby / SWEDEN				
Tested to radio standards specification no.	:	RSS 210, Issue 8, Annex 8				
Open area test site IC No.	:	IC 3462C-1				
Frequency range	:	lowest channel 2402 MHz, highest channel 2480 MHz				
RF-power [W] (max.)	:	Cond.: 1.1 mW (GFSK modulation) EIRP: 0.8 mW (GFSK modulation) Cond.: 0.7 mW (Pi/4-DQPSK modulation) EIRP: 0.4 mW (Pi/4-DQPSK modulation) Cond.: 0.7 mW (8DPSK modulation) EIRP: 0.5 mW (8DPSK modulation)				
Occupied bandwidth (99%-BW) [kHz]	:	745 (GFSK modulation) 1125 (Pi/4-DQPSK modulation) 1168 (8DPSK modulation)				
Type of modulation	:	FHSS technology with GFSK, Pi/4 DQPSK and 8 DPSK modulation.				
Emission designator (TRC-43)	:	745 KFXD (GFSK modulation) 1M13GXD (Pi/4-DQPSK modulation) 1M17GXD (8DPSK modulation)				
Antenna information	:	Integrated antenna				
Transmitter spurious (worst case) [dBµV/m @ 3	m]:	47.07 dBμV/m @ 19.5 GHz				

ATTESTATION: DECLARATION OF COMPLIANCE:

I attest that the testing was performed or supervised by me; that the test measurements were made in accordance with the above-mentioned Industry Canada standard(s); and that the equipment identified in this application has been subjected to all the applicable test conditions specified in the Industry Canada standards and all of the requirements of the standard have been met.

Laboratory manager:

2013-08-29	Andreas Luckenbill			
Date	Name	Signature		

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11	Measurement results	
11.1	Antenna gain	
	<u> </u>	Not performed!
11.2	Power spectral density	
	Not requ	uired for hopping systems!
11.3	Carrier frequency separation	
		Not performed!
11.4	Number of hopping channels	
		Not performed!
11.5	Time of occupancy (dwell time)	
		Not performed!
11.6	Spectrum bandwidth of a FHSS	system - 20 dB bandwidth

Not performed!

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11.7 Maximum output power

Description:

Measurement of the maximum output power radiated. EUT in single channel mode. EUT configuration is made by Marvell Chip configuration tool.

Measurement:

Measurement parameter			
Detector:	Peak		
Sweep time:	Auto		
Video bandwidth:	3 MHz		
Resolution bandwidth:	3 MHz		
Span:	5 MHz		
Trace-Mode:	Max Hold		

Limits:

FCC	IC		
Maximum output power			
Systems using more that	antenna gain max. 6 dBi] an 75 hopping channels: ntenna gain max. 6 dBi		

Results:

Modulation	Maximum output power radiated - EIRP [dBm]				
Frequency	2402 MHz	2441 MHz	2480 MHz		
GFSK	-1.0	-2.7	-2.3		
Pi/4 DQPSK	-4.0	-5.9	-5.6		
8DPSK	-3.0	-4.8	-3.7		
Measurement uncertainty	± 3 dB				

Result: Passed

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11.8 Band edge compliance conducted

Not performed!

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11.9 Band edge compliance radiated

Description:

Measurement of the radiated band edge compliance. The EUT is turned in the position that results in the maximum level at the band edge. Then a sweep over the corresponding restricted band is performed. The EUT is set to single channel mode and the transmit channel is channel 00 for the lower restricted band and channel 78 for the upper restricted band. The measurement is repeated for all modulations. Measurement distance is 3m.

Measurement:

Measurement parameter			
Detector:	Peak		
Sweep time:	Auto		
Video bandwidth:	1 MHz Peak / 10 Hz AVG		
Resolution bandwidth:	1 MHz		
Span:	Lower Band: 2370 – 2400 MHz Upper Band: 2480 – 2500 MHz		
Trace-Mode:	Max Hold		

Limits:

FCC	IC		
Band edge com	pliance radiated		
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in Section 15.205(a), must also comply with the radiated emission limits specified in Section 15.209(a) (see Section 5.205(c)).			
54 dBμ\ 74 dBμ\	//m AVG //m Peak		

Results:

Scenario	Band edge compliance radiated [dBμV/m]			
Modulation	GFSK Pi/4 DQPSK 8DPSk			
Lower restricted band	< 54 AVG / < 74 PP	< 54 AVG / < 74 PP	< 54 AVG / < 74 PP	
Upper restricted band	< 54 AVG / < 74 PP	< 54 AVG / < 74 PP	< 54 AVG / < 74 PP	
Measurement uncertainty	± 3 dB			

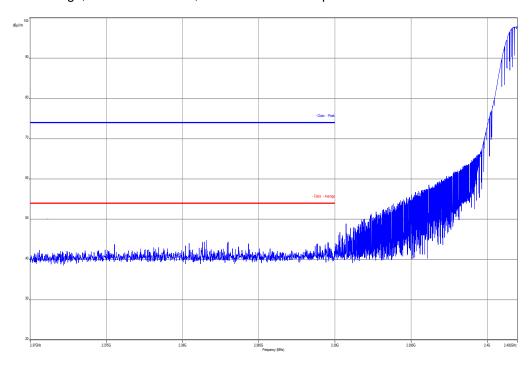
Result: Passed

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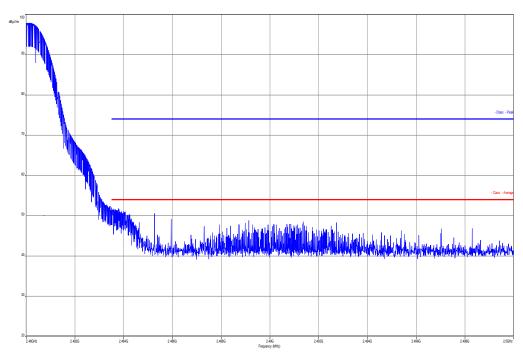


Plots:

Plot 1: Lower band edge, GFSK modulation, vertical & horizontal polarization



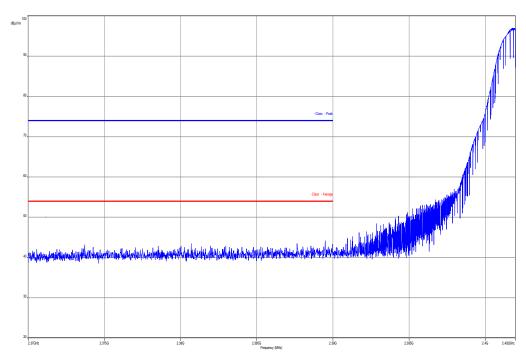
Plot 2: Upper band edge, GFSK modulation, vertical & horizontal polarization



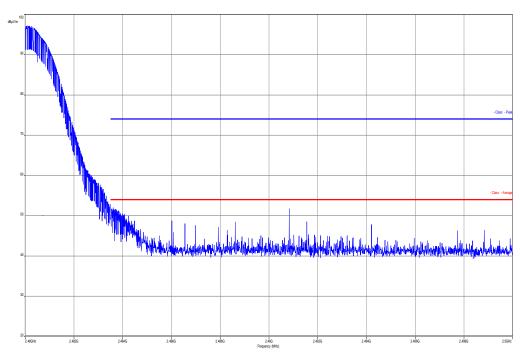
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Plot 3: Lower band edge, Pi/4 DQPSK modulation, vertical & horizontal polarization



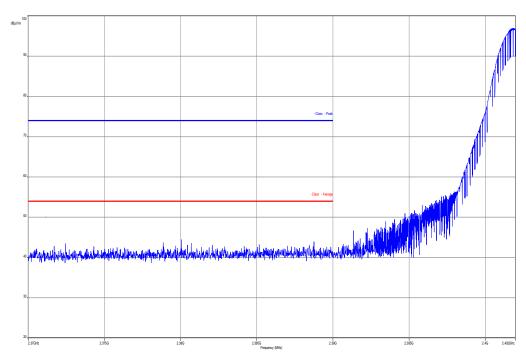
Plot 4: Upper band edge, Pi/4 DQPSK modulation, vertical & horizontal polarization



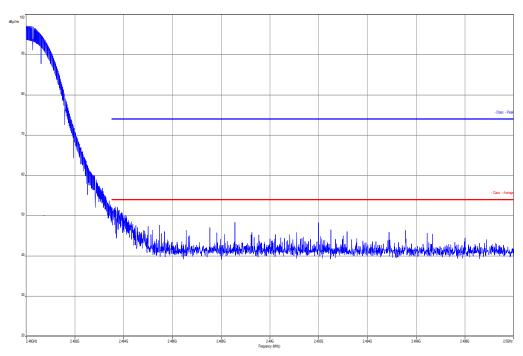
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Plot 5: Lower band edge, 8 DPSK modulation, vertical & horizontal polarization



Plot 6: Upper band edge, 8 DPSK modulation, vertical & horizontal polarization



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11.10 TX spurious emissions conducted

Not performed!

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11.11 TX spurious emissions radiated

Description:

Measurement of the radiated spurious emissions in transmit mode. The EUT is set to single channel mode and the transmit channel is channel 00, channel 39 and channel 78. The measurement is performed in the mode with the highest output power.

Measurement:

Measurement parameter				
Detector:	Peak / Quasi Peak			
Sweep time:	Auto			
Video bandwidth:	Sweep: 100 kHz Remeasurement: 10 Hz			
Resolution bandwidth:	F < 1 GHz: 100 kHz F > 1 GHz: 1 MHz			
Span:	30 MHz to 25 GHz			
Trace-Mode:	Max Hold			
Measured Modulation:	☐ GFSK ☐ Pi/4 DQPSK ☐ 8DPSK			

The modulation with the highest output power was used to perform the transmitter spurious emissions. If spurious were detected a re-measurement was performed on the detected frequency with each modulation.

Limits:

FCC			IC			
	TX spurious em	issions radiated				
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).						
	§15	209				
Frequency (MHz)	Field streng	th (dBµV/m)	Measurement distance			
30 - 88 30.0 10						
88 – 216 33.5 10						
216 – 960	216 – 960 36.0 10					
Above 960	Above 960 54.0 3					

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Results:

	TX spurious emissions radiated [dBμV/m]							
	2402 MHz		2441 MHz		2480 MHz			
F [MHz]	Detector	Level [dBµV/m]	F [MHz] Detector Level [dBµV/m]			F [MHz]	Detector	Level [dBµV/m]
	ons below 1 Cook at the table 1 GHz plot.		For emissions below 1 GHz, please take a look at the table below the 1 GHz plot.			For emissions below 1 GHz, please take a look at the table below the 1 GHz plot.		
Meas	Measurement uncertainty ± 3 dB							

Result: Passed

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Plots:

Plot 1: 30 MHz to 1 GHz, TX mode, channel 00, vertical & horizontal polarization

Common Information

EUT: FLIR-E64501 (Exx)

Serial Number:

Test Description: FCC part 15 C class B @ 10 m

Operating Conditions: BT TX Ch. 00 (DH5)

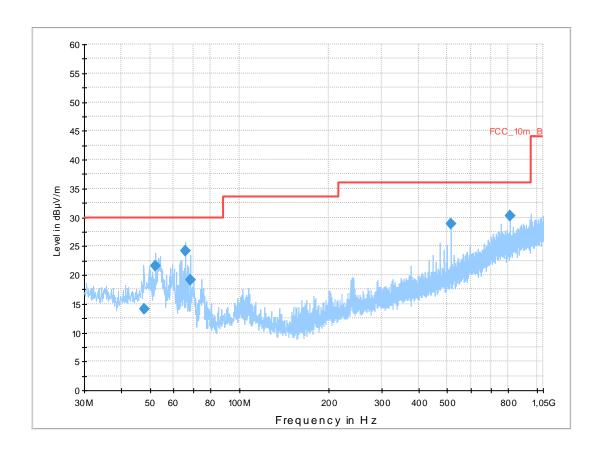
Operator Name: Hennemann AC: 115 V / 60 Hz;

Scan Setup: STAN_Fin [EMI radiated]

Hardware Setup: Electric Field (NOS)

Receiver: [ESCI 3] Level Unit: dBµV/m

SubrangeStep SizeDetectorsIF BWMeas. Time30 MHz - 2 GHz60 kHzQPK120 kHz1 s20 dB



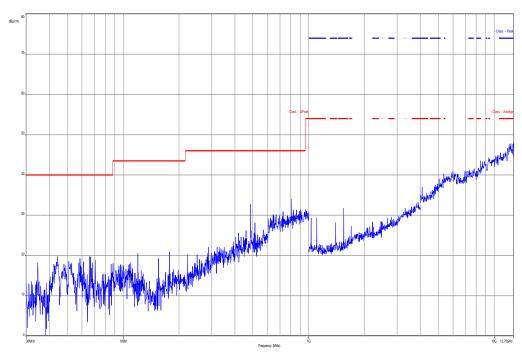
Final Result 1

Frequency (MHz)	QuasiPeak (dBµV/m)	Meas. Time (ms)	Bandwidt h (kHz)	Height (cm)	Polarizatio n	Azimut h (deg)	Corr. (dB)	Margi n (dB)	Limit (dBµV/m)	Comment
47.767950	14.0	1000.0	120.000	170.0	V	190.0	13.3	16.0	30.0	
52.190100	21.6	1000.0	120.000	98.0	V	190.0	13.2	8.4	30.0	
65.705850	24.1	1000.0	120.000	170.0	V	100.0	10.2	5.9	30.0	
68.391900	19.1	1000.0	120.000	170.0	V	280.0	9.6	10.9	30.0	
513.019200	29.0	1000.0	120.000	170.0	Н	190.0	18.9	7.0	36.0	
810.118200	30.3	1000.0	120.000	98.0	Н	100.0	24.0	5.7	36.0	

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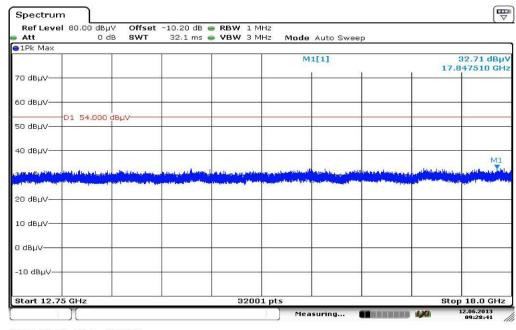


Plot 2: 1 GHz to 12.75 GHz, TX mode, channel 00, vertical & horizontal polarization



The carrier signal is notched with a 2.4 GHz band rejection filter.

Plot 3: 12.75 GHz to 18 GHz, TX mode, channel 00, vertical & horizontal polarization

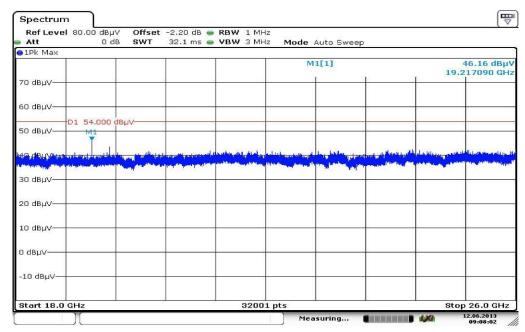


Date: 12.JUN.2013 09:28:41

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Plot 4: 18 GHz to 26 GHz, TX mode, channel 00, vertical & horizontal polarization



Date: 12.JUN.2013 09:08:02

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Plot 5: 30 MHz to 1 GHz, TX mode, channel 39, vertical & horizontal polarization

Common Information

EUT: FLIR-E64501 (Exx)

Serial Number:

Test Description: FCC part 15 C class B @ 10 m

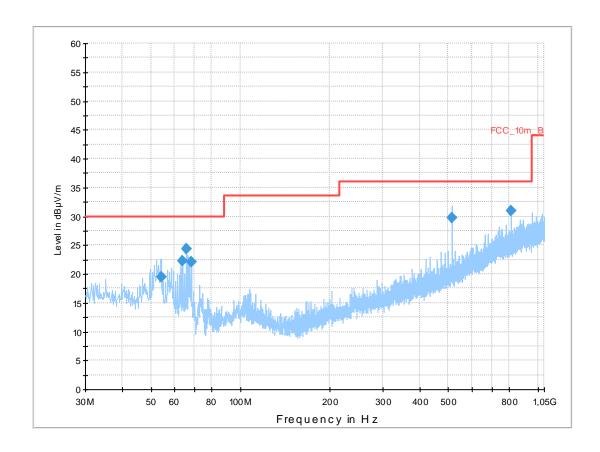
Operating Conditions: BT TX Ch. 39 (DH5)

Operator Name: Hennemann AC: 115 V / 60 Hz;

Scan Setup: STAN_Fin [EMI radiated]

Hardware Setup: Electric Field (NOS)

Receiver: [ESCI 3] Level Unit: dBµV/m



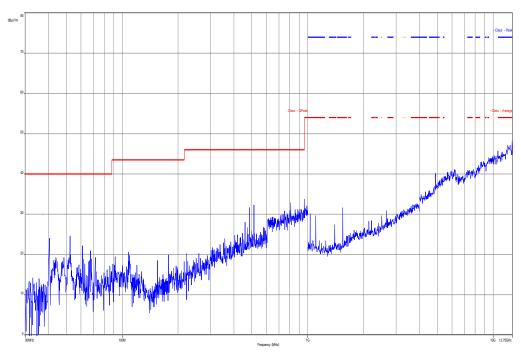
Final Result 1

Frequency (MHz)	QuasiPeak (dBµV/m)	Meas. Time (ms)	Bandwidt h (kHz)	Height (cm)	Polarizatio n	Azimut h (deg)	Corr. (dB)	Margi n (dB)	Limit (dBµV/m)	Comment
53.955750	19.4	1000.0	120.000	170.0	V	190.0	13.0	10.6	30.0	
63.870450	22.2	1000.0	120.000	170.0	V	0.0	10.7	7.8	30.0	
65.655600	24.4	1000.0	120.000	170.0	V	190.0	10.3	5.6	30.0	
68.378400	22.1	1000.0	120.000	170.0	V	81.0	9.6	7.9	30.0	
513.006750	29.8	1000.0	120.000	170.0	Н	190.0	18.9	6.2	36.0	
810.102900	30.9	1000.0	120.000	111.0	Н	100.0	24.0	5.1	36.0	

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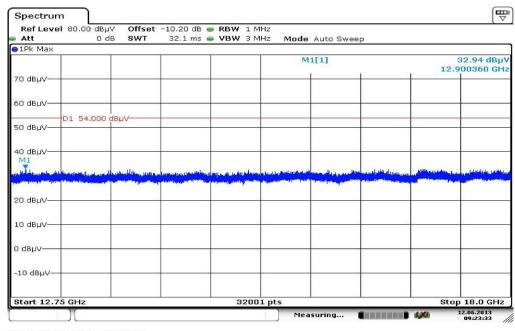


Plot 6: 1 GHz to 12.75 GHz, TX mode, channel 39, vertical & horizontal polarization



The carrier signal is notched with a 2.4 GHz band rejection filter.

Plot 7: 12.75 GHz to 18 GHz, TX mode, channel 39, vertical & horizontal polarization

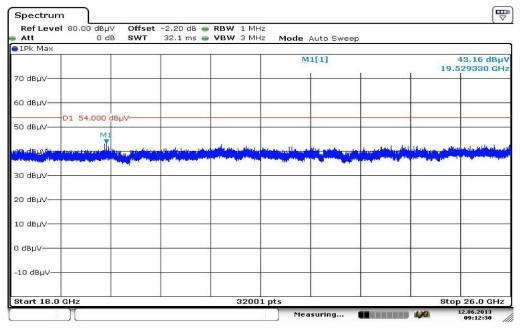


Date: 12.JUN.2013 09:23:33

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Plot 8: 18 GHz to 26 GHz, TX mode, channel 39, vertical & horizontal polarization



Date: 12.JUN.2013 09:12:30

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Plot 9: 30 MHz to 1 GHz, TX mode, channel 78, vertical & horizontal polarization

Common Information

EUT: FLIR-E64501 (Exx)

Serial Number:

Test Description: FCC part 15 C class B @ 10 m

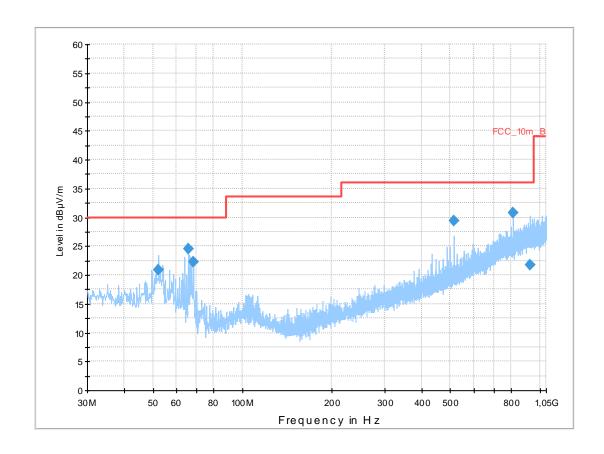
Operating Conditions: BT TX Ch. 78 (DH5)

Operator Name: Hennemann AC: 115 V / 60 Hz;

Scan Setup: STAN_Fin [EMI radiated]

Hardware Setup: Electric Field (NOS)

Receiver: [ESCI 3] Level Unit: dBµV/m



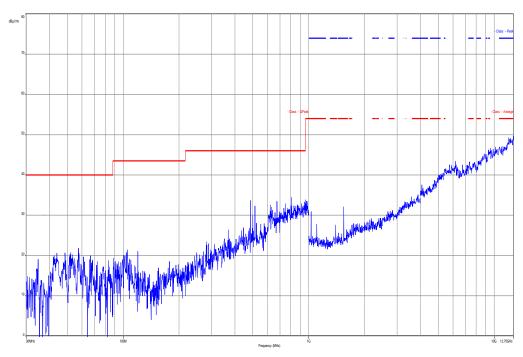
Final Result 1

Frequency (MHz)	QuasiPeak (dBµV/m)	Meas. Time (ms)	Bandwidt h (kHz)	Height (cm)	Polarizatio n	Azimut h (deg)	Corr. (dB)	Margi n (dB)	Limit (dBµV/m)	Comment
52.156800	20.8	1000.0	120.000	98.0	V	81.0	13.2	9.2	30.0	
65.641500	24.5	1000.0	120.000	170.0	V	-9.0	10.3	5.5	30.0	
68.354700	22.3	1000.0	120.000	170.0	V	-5.0	9.6	7.7	30.0	
513.017700	29.4	1000.0	120.000	170.0	Н	190.0	18.9	6.6	36.0	
810.094050	30.8	1000.0	120.000	98.0	Н	100.0	24.0	5.2	36.0	
926.578350	21.8	1000.0	120.000	170.0	Н	179.0	25.3	14.2	36.0	

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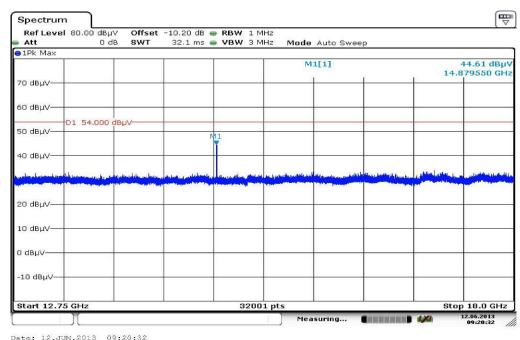


Plot 10: 1 GHz to 12.75 GHz, TX mode, channel 78, vertical & horizontal polarization



The carrier signal is notched with a 2.4 GHz band rejection filter.

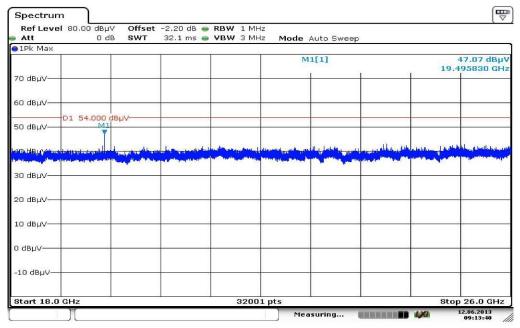
Plot 11: 12.75 GHz to 18 GHz, TX mode, channel 78, vertical & horizontal polarization



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Plot 12: 18 GHz to 26 GHz, TX mode, channel 78, vertical & horizontal polarization



Date: 12.JUN.2013 09:13:40

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11.12 RX spurious emissions radiated

Description:

Measurement of the radiated spurious emissions in idle/receive mode. The EUT is detached so all oscillators are active.

Measurement:

Measurement parameter								
Detector:	Peak / Quasi peak							
Sweep time:	Auto							
Video bandwidth:	Sweep: 100 kHz Remeasurement: 10 Hz							
Resolution bandwidth:	F < 1 GHz: 100 kHz F > 1 GHz: 1 MHz							
Span:	30 MHz to 25 GHz							
Trace-Mode:	Max Hold							

Limits:

FCC		IC							
RX Spurious Emissions Radiated									
Frequency (MHz)	Field streng	th (dBµV/m)	Measurement distance						
30 - 88	30	0.0	10						
88 – 216	33	3.5	10						
216 – 960	36	5.0	10						
Above 960	54	1.0	3						

Results:

RX spurious emissions radiated [dBμV/m]									
F [MHz]	Detector	Level [dBµV/m]							
	No peaks detected								
Measurement uncertainty	±3	dB							

Result: Passed

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Plots:

Plot 1: 30 MHz to 1 GHz, RX mode, vertical & horizontal polarization

Common Information

EUT: FLIR-E64501 (Exx)

Serial Number:

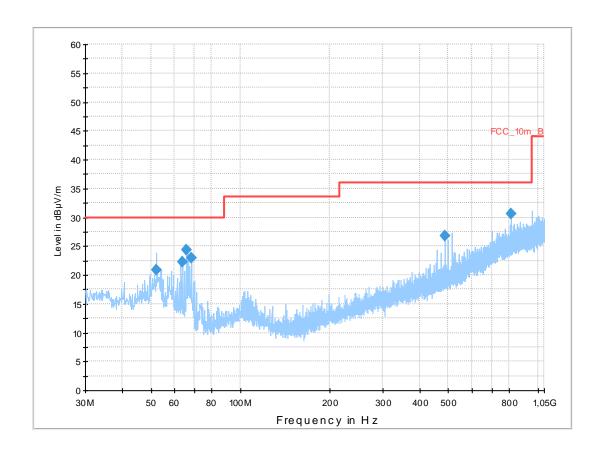
Test Description: FCC part 15 C class B @ 10 m

Operating Conditions: BT RX (DH5)
Operator Name: Hennemann
Comment: AC: 115 V / 60 Hz;

Scan Setup: STAN_Fin [EMI radiated]

Hardware Setup: Electric Field (NOS)

Receiver: [ESCI 3] Level Unit: $dB\mu V/m$



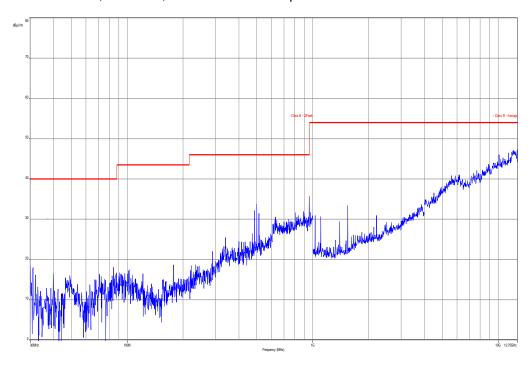
Final Result 1

Frequency (MHz)	QuasiPeak (dBµV/m)	Meas. Time (ms)	Bandwidt h (kHz)	Height (cm)	Polarizatio n	Azimut h (deg)	Corr. (dB)	Margi n (dB)	Limit (dBµV/m)	Comment
52.163850	20.9	1000.0	120.000	98.0	V	10.0	13.2	9.1	30.0	
63.845850	22.2	1000.0	120.000	170.0	V	100.0	10.7	7.8	30.0	
65.665800	24.4	1000.0	120.000	170.0	V	90.0	10.3	5.6	30.0	
68.348850	23.0	1000.0	120.000	170.0	V	90.0	9.7	7.0	30.0	
486.016950	26.9	1000.0	120.000	170.0	Н	10.0	18.4	9.1	36.0	
810.097650	30.6	1000.0	120.000	130.0	Н	100.0	24.0	5.4	36.0	

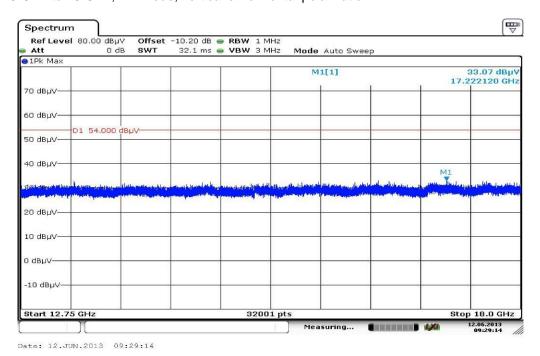
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Plot 2: 1 GHz to 12.75 GHz, RX mode, vertical & horizontal polarization



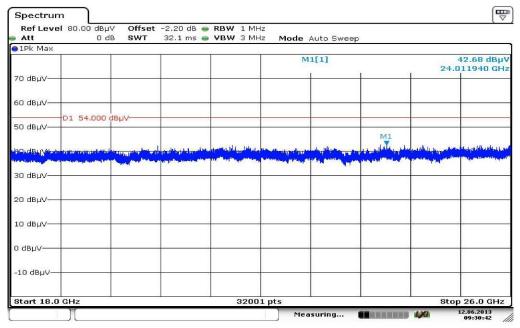
Plot 3: 12.75 GHz to 18 GHz, RX mode, vertical & horizontal polarization



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Plot 4: 18 GHz to 26 GHz, RX mode, vertical & horizontal polarization



Date: 12.JUN.2013 09:30:42

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11.13 Spurious emissions radiated < 30 MHz

Description:

Measurement of the radiated spurious emissions in transmit mode below 30 MHz. The EUT is set to single channel mode and the transmit channel is channel 39. This measurement is representative for all channels and modes. If critical peaks are found channel 00 and channel 78 will be measured too. The measurement is performed in the mode with the highest output power. The limits are recalculated to a measurement distance of 3 m with 40 dB/decade according CFR Part 2.

Measurement:

Measureme	Measurement parameter									
Detector:	Peak / Quasi peak									
Sweep time:	Auto									
Video bandwidth:	F < 150 kHz: 200 Hz F > 150 kHz: 9 kHz									
Resolution bandwidth:	F < 150 kHz: 1 kHz F > 150 kHz: 100 kHz									
Span:	9 kHz to 30 MHz									
Trace-Mode:	Max Hold									

Limits:

FCC		IC							
TX spurious emissions radiated < 30 MHz									
Frequency (MHz)	Field streng	th (dBµV/m)	Measurement distance						
0.009 – 0.490	2400/I	F(kHz)	300						
0.490 – 1.705	24000/F(kHz)		30						
1.705 – 30.0	3	0	30						

Results:

TX sp	TX spurious emissions radiated < 30 MHz [dBµV/m]								
F [MHz]	Detector	Level [dBµV/m]							
No peaks detected									
Measurement uncertainty	Measurement uncertainty ± 3 dB								

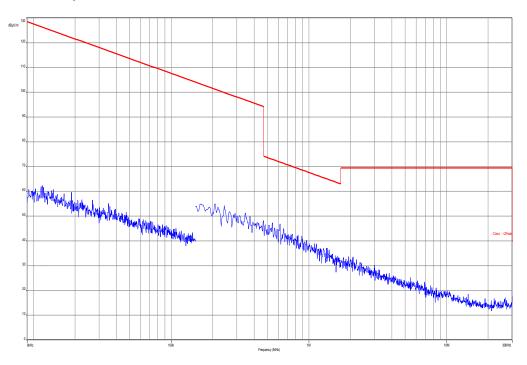
Result: Passed

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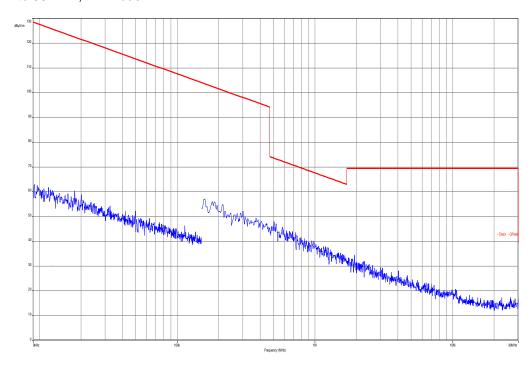


Plots:

Plot 1: 9 kHz to 30 MHz, TX mode



Plot 2: 9 kHz to 30 MHz, RX mode



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11.14 Spurious emissions conducted < 30 MHz

Not performed!

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12 Test equipment and ancillaries used for tests

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, rf-generating and signalling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Labor/Item).

No.	Lab / Item	Equipment	Туре	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	45	Switch-Unit	3488A	HP Meßtechnik	2719A14505	300000368	g		
2	50	DC power supply, 60Vdc, 50A, 1200 W	6032A	HP Meßtechnik	2920A04466	300000580	ne		
3	n. a.	software	SPS_PHE 1.4f	Spitzberger & Spieß	B5981; 5D1081;B597 9	300000210	ne		
4	n. a.	EMI Test Receiver	ESCI 3	R&S	100083	300003312	k	09.01.2013	09.01.2014
5	n. a.	Analyzer- Reference- System (Harmonics and Flicker)	ARS 16/1	SPS	A3509 07/0 0205	300003314	k	14.07.2011	14.07.2013
6	n. a.	Amplifier	JS42- 00502650- 28-5A	MITEQ	1084532	300003379	ev		
7	n. a.	Antenna Tower	Model 2175	ETS- LINDGREN	64762	300003745	izw		
8	n. a.	Positioning Controller	Model 2090	ETS- LINDGREN	64672	300003746	izw		
9	n. a.	Turntable Interface-Box	Model 105637	ETS- LINDGREN	44583	300003747	izw		
10	n. a.	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbe ck	295	300003787	k	12.04.2012	12.04.2014
11	n. a.	Spectrum- Analyzer	FSU26	R&S	200809	300003874	k	16.01.2013	16.01.2014
12	n. a.	Double-Ridged Waveguide Horn Antenna 1-18.0GHz	3115	EMCO	8812-3088	300001032	vIKI!	08.05.2013	08.05.2015
13	n. a.	Active Loop Antenna 10 kHz to 30 MHz	6502	EMCO	8905-2342	300000256	vIKI!	13.06.2013	13.06.2015
14	n. a.	Anechoic chamber	FAC 3/5m	MWB / TDK	87400/02	300000996	ev		
15	n. a.	Switch / Control Unit	3488A	HP Meßtechnik	*	300000199	ne		
16	n. a.	Switch / Control Unit	3488A	HP Meßtechnik	2719A15013	300001156	ne		
17	n. a.	Three-Way Power Splitter, 50 Ohm	11850C	HP Meßtechnik		300000997	ne		
18	n. a.	Amplifier	js42- 00502650- 28-5a	Parzich GMBH	928979	300003143	ne		
19	n. a.	Band Reject filter	WRCG240 0/2483- 2375/2505- 50/10SS	Wainwright	11	300003351	ev		
20	n. a.	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbe ck	371	300003854	vIKI!	14.10.2011	14.10.2014
21	n. a.	MXE EMI Receiver 20 Hz bis 26,5 GHz	N9038A	Agilent Technologi es	MY51210197	300004405	k	21.02.2013	21.02.2014
22	n.a.	Signal Analyzer	FSV40	R&S	101042	300004517	k	22.10.2012	22.10.2013

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		40 GHz						
23	11b	Microwave System Amplifier, 0.5- 26.5 GHz	83017A	HP Meßtechnik	00419	300002268	ev	
24	A025	Std. Gain Horn Antenna 12.4 to 18.0 GHz	639	Narda		300000786	ne	
25	A027	Std. Gain Horn Antenna 18.0 to 26.5 GHz	638	Narda		300000486	ne	

Agenda: Kind of Calibration

k calibration / calibrated EK limited calibration
ne not required (k, ev, izw, zw not required) zw cyclical maintenance (external cyclical maintenance)
ev periodic self verification izw internal cyclical maintenance

Ve long-term stability recognized g blocked for accredited testing vlkl! Attention: extended calibration interval

NK! Attention: not calibrated *) next calibration ordered / currently in progress

13 Observations

No observations exceeding those reported with the single test cases have been made.

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Annex A Document history

Version	Applied changes	Date of release
1.0	Initial release	2013-06-19
-A	Editorial changes	2013-08-29

Annex B Further information

Glossary

AVG - Average

DUT - Device under test

EMC - Electromagnetic Compatibility

EN - European Standard EUT - Equipment under test

ETSI - European Telecommunications Standard Institute

FCC - Federal Communication Commission

FCC ID - Company Identifier at FCC

Serial number

HW - Hardware
IC - Industry Canada
Inv. No. - Inventory number
N/A - Not applicable
PP - Positive peak
QP - Quasi peak

SW - Software

S/N

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Annex C Accreditation Certificate



Note:

The current certificate including annex is published on our website (see link below) or may be received from CETECOM ICT Services on request.

http://www.cetecom.com/eu/de/cetecom-group/europa/deutschland-saarbruecken/akkreditierungen.html

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